	Search Notes						
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Application/Control No.	Applicant(s)/Patent under Reexamination		
10/723,693	PHUNG ET AL.		
Examiner	Art Unit		
Tanh Q. Nguyen	2182		

SEARCHED				
Class	Subclass	Date	Examiner	
710	1,5,8,10,20 21,104,505 306,311,312	03/04/06	TON	
703	203, 220-222			
713	1,2,100	- J	1	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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East Search - updated results attached inventor search - East mydold	02/09/07	TON		
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